

April 1988 Revised July 1999

74F175 Quad D-Type Flip-Flop

General Description

The 74F175 is a high-speed quad D-type flip-flop. The device is useful for general flip-flop requirements where clock and clear inputs are common. The information on the D inputs is stored during the LOW-to-HIGH clock transition. Both true and complemented outputs of each flip-flop are provided. A Master Reset input resets all flip-flops, independent of the Clock or D inputs, LOW.

Features

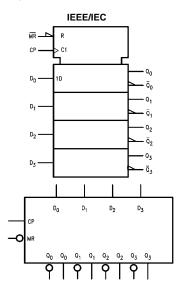
- Edge-triggered D-type inputs
- Buffered positive edge-triggered clock
- Asynchronous common reset
- True and complement output

Ordering Code:

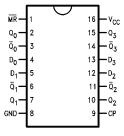
Order Number	Package Number	Package Description
74F175SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
74F175SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74F175PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols



Connection Diagram



Unit Loading/Fan Out

Din Names	Description	U.L.	Input I _{IH} /I _{IL}	
Pin Names	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
D ₀ -D ₃	Data Inputs	1.0/1.0	20 μA/-0.6 mA	
CP	Clock Pulse Input (Active Rising Edge)	1.0/1.0	20 μA/-0.6 mA	
MR	Master Reset Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA	
$Q_0 - Q_3$	True Outputs	50/33.3	−1 mA/20 mA	
$\overline{Q}_0 - \overline{Q}_3$	Complement Outputs	50/33.3	−1 mA/20 mA	

Functional Description

The 74F175 consists of four edge-triggered D-type flipflops with individual D inputs and Q and $\overline{\mathsf{Q}}$ outputs. The Clock and Master Reset are common. The four flip-flops will store the state of their individual D inputs on the LOWto-HIGH clock (CP) transition, causing individual Q and $\overline{\mathbf{Q}}$ outputs to follow. A LOW input on the Master Reset (MR) will force all Q outputs LOW and Q outputs HIGH independent of Clock or Data inputs. The 74F175 is useful for general logic applications where a common Master Reset and Clock are acceptable.

Truth Table

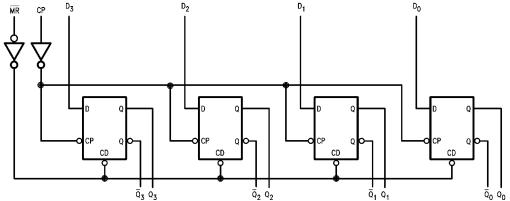
	Inputs	Outputs			
MR	MR CP		Q _n	$\overline{\overline{Q}}_n$	
L	Х	Х	L	Н	
Н	~	Н	Н	L	
н	~	L	L	Н	

- H = HIGH Voltage Level L = LOW Voltage Level

- X = Immaterial

 ✓ = LOW-to-HIGH Clock Transition

Logic Diagram



 $\bar{Q}_3 \ Q_3 \\ \hline{Q}_1 \ Q_2 \\ \hline{Q}_2 \ Q_2 \\ \hline{Q}_1 \ Q_1 \\ \hline{Q}_1 \ Q_1 \\ \hline{Q}_1 \ Q_1 \\ \hline{Q}_1 \ Q_2 \\ \hline{Q}_2 \ Q_2 \\ \hline{Q}$

Absolute Maximum Ratings(Note 1)

-65°C to +150°C Storage Temperature Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias -55°C to +150°C V_{CC} Pin Potential to Ground Pin -0.5V to +7.0VInput Voltage (Note 2) -0.5V to +7.0V

Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

Standard Output -0.5V to V_{CC} -0.5V to +5.5V

3-STATE Output

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA)

Recommended Operating Conditions

0°C to +70°C Free Air Ambient Temperature Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

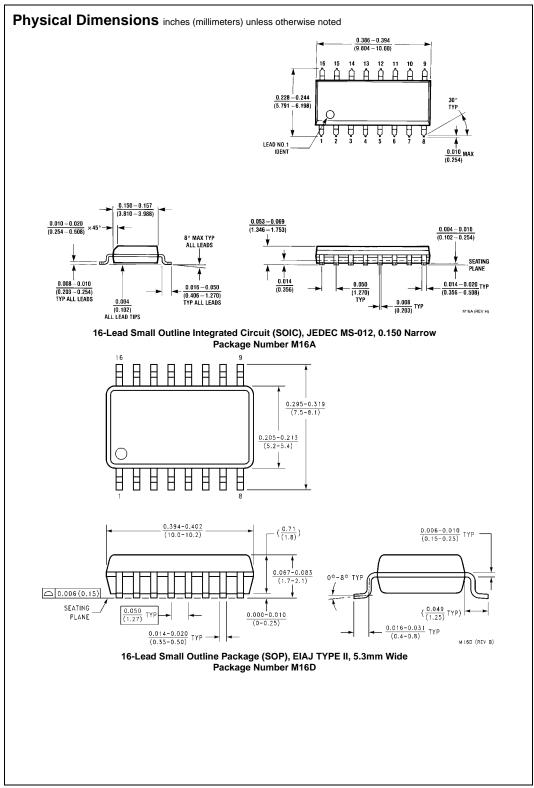
Symbol	Parameter		Min	Тур	Max	Units	V _{CC}	Conditions
V _{IH}	Input HIGH Voltage		2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage				8.0	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage				-1.2	V	Min	$I_{IN} = -18 \text{ mA}$
V _{OH}	Output HIGH Voltage	10% V _{CC} 5% V _{CC}	2.5 2.7			V	Min	$I_{OH} = -1 \text{ mA}$ $I_{OH} = -1 \text{ mA}$
V _{OL}	Output LOW Voltage	10% V _{CC}			0.5	٧	Min	I _{OL} = 20 mA
I _{IH}	Input HIGH Current				5.0	μА	Max	V _{IN} = 2.7V
I _{BVI}	Input HIGH Current Breakdown Test				7.0	μА	Max	V _{IN} = 7.0V
I _{CEX}	Output HIGH Leakage Current				50	μА	Max	V _{OUT} = V _{CC}
V _{ID}	Input Leakage Test		4.75			V	0.0	$I_{ID} = 1.9 \mu A$ All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current				3.75	μА	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IL}	Input LOW Current				-0.6	mA	Max	V _{IN} = 0.5V
los	Output Short-Circuit Current		-60		-150	mA	Max	V _{OUT} = 0V
Icc	Power Supply Current			22.5	34.0	mA	Max	$CP = \checkmark$ $D_n = \overline{MR} = HIGH$

AC Electrical Characteristics

Symbol	Parameter		$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$ $C_L = 50$ pF	
		Min	Тур	Max	Min	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	100	140		80		100		MHz
t _{PLH}	Propagation Delay	4.0	5.0	6.5	3.5	8.5	4.0	7.5	
t_{PHL}	CP to Q_n or \overline{Q}_n	4.0	6.5	8.5	4.0	10.5	4.0	9.5	ns
t _{PHL}	Propagation Delay MR to Q _n	4.5	9.0	11.5	4.5	15.0	4.5	13.0	ns
t _{PLH}	Propagation Delay MR to Q _n	4.0	6.5	8.0	4.0	10.0	4.0	9.0	ns

AC Operating Requirements

Symbol	Parameter		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$		$T_A = -55^{\circ}C$ to $+125^{\circ}C$ $V_{CC} = +5.0V$		$T_A = 0$ °C to +70°C $V_{CC} = +5.0V$	
		Min	Max	Min	Max	Min	Max	
t _S (H)	Setup Time, HIGH or LOW	3.0		3.0		3.0		
t _S (L)	D _n to CP	3.0		3.0		3.0		ns
t _H (H)	Hold Time, HIGH or LOW	1.0		1.0		1.0		
$t_H(L)$	D _n to CP	1.0		2.0		1.0		
t _W (H)	CP Pulse Width	4.0		4.0		4.0		no
$t_W(L)$	HIGH or LOW	5.0		5.0		5.0		ns
t _W (L)	MR Pulse Width, LOW	5.0		5.0		5.0		ns
t _{REC}	Recovery Time, MR to CP	5.0		5.0		5.0		ns



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Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.780 0.090 (18.80 - 19.81)(2.286)**16 15 14 13 12 11 10 9** 16 T5 F INDEX AREA 0.250 ± 0.010 $\overline{(6.350 \pm 0.254)}$ PIN NO. 1 PIN NO. 1 1 2 3 4 5 6 7 8 1 2 _ OPTION 01 OPTION 02 0.065 $\frac{0.130 \pm 0.005}{(3.302 \pm 0.127)}$ $\frac{0.060}{(1.524)}$ TYP (1.651)4° TYP 0.300 - 0.320OPTIONAL (7.620 - 8.128) 0.145 - 0.200 $\overline{(3.683 - 5.080)}$ 95°±5° $\frac{0.008 - 0.016}{(0.203 - 0.406)}$ TYP 90° ± 4° TYP 0.020 $\frac{0.280}{(7.112)}$ MIN (0.508)0.125 - 0.150 (3.175 - 3.810) 0.030 ± 0.015 (0.762 ± 0.381) 0.014 - 0.023 0.100 ± 0.010 (0.325 +0.040 -0.015 (0.356 - 0.584) (2.540 ± 0.254) 0.050 ± 0.010 N16E (REV F) TYP (1.270 ± 0.254)

16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

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